

N-Channel 30 V (D-S) MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	30			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.00062			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.00093			
Q _g typ. (nC)	59.7			
I _D (A)	100 ^{a, g}			
Configuration	Single			

FEATURES

• TrenchFET® Gen IV power MOSFET



 \bullet Optimized $Q_g,\ Q_{gd},\ and\ Q_{gd}/Q_{gs}$ ratio reduces switching related power loss

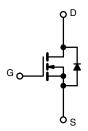
COMPLIANT HALOGEN **FREE**

100 % R_a and UIS tested

· Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

APPLICATIONS

- Synchronous rectification
- High power density DC/DC
- · Synchronous buck converter
- OR-ing
- · Load switching
- · Battery management



N-Channel MOSFET

ORDERING INFORMATION	
Package	PowerPAK SO-8
Lead (Pb)-free and halogen-free	SiRA80DP-T1-RE3

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	30	V	
Gate-source voltage		V _{GS}	+20 / -16	V	
	T _C = 25 °C		100 ^a		
Continuous drain current (T _J = 150 °C)	T _C = 70 °C	1	100 ^a		
	T _A = 25 °C	l _D	82 b, c		
	T _A = 70 °C	1	66 ^{b, c}	^	
Pulsed drain current (t = 100 μs)		I _{DM}	200	A	
Continuous source-drain diode current	T _C = 25 °C	_	94.5		
	T _A = 25 °C	l _S	5.6 ^{b, c}		
Single pulse avalanche current L = 0.1 mH		I _{AS}	45		
Single pulse avalanche energy	L = 0.1 IIII	E _{AS}	101	mJ	
Maximum power dissipation	T _C = 25 °C		104		
	T _C = 70 °C	P _D	66.6	w	
	T _A = 25 °C		6.25 ^{b, c}	VV	
	T _A = 70 °C	1	4 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) ^c			260		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient ^b	t ≤ 10 s	R _{thJA}	15	20	°C/W	
Maximum junction-to-case (drain)	Steady state	$R_{th,IC}$	0.9	1.2] 0///	

Notes

- Package limited
 Surface mounted on 1" x 1" FR4 board
- See solder profile (www.vishay.com/doc?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components Maximum under steady state conditions is 54 °C/W
- $T_C = 25 \, ^{\circ}C$



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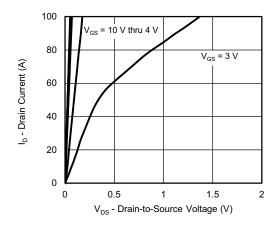
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 10 mA	-	15	-		
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	ı	-5.3	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1	-	2.2	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ / } -16 \text{ V}$	-	-	100	nA	
-	,	V _{DS} = 30 V, V _{GS} = 0 V	-	-	1		
Zero gate voltage drain current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 70 °C	-	-	15	μA	
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	20	-	-	Α	
Duein accuracy on state weststands 2	Б	V _{GS} =10 V, I _D = 20 A	-	0.00047	0.00062	_	
Drain-source on-state resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$	-	0.00071	0.00093	Ω	
Forward transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 30 A	-	125	-	S	
Dynamic ^b					•	•	
Input capacitance	C _{iss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz	-	9530	-	pF	
Output capacitance	C _{oss}		-	4280	-		
Reverse transfer capacitance	C _{rss}		-	626	-		
	0	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	ı	125	188		
Total gate charge	Q_g		-	59.7	90		
Gate-source charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$	-	25.2	-	nC	
Gate-drain charge	Q_{gd}		-	12.3	-		
Gate resistance	R_{g}	f = 1 MHz	0.1	0.4	0.8	Ω	
Turn-on delay time	t _{d(on)}		-	17	35		
Rise time	t _r	$V_{DD} = 15 \text{ V}, R_L = 1.5 \Omega, I_D \cong 10 \text{ A}, \ V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	23	50		
Turn-off delay time	t _{d(off)}		1	41	80		
Fall time	t _f		-	12	25	1	
Turn-on delay time	t _{d(on)}		-	40	80	ns	
Rise time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_L = 1.5 \Omega, \text{ I}_D \cong 10 \text{ A},$	1	66	135	- -	
Turn-off delay time	t _{d(off)}	$V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	-	50	100		
Fall time	t _f		-	35	70		
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	IS	T _C = 25 °C	-	-	94.5	^	
Pulse diode forward current	I _{SM}		1	-	200	A	
Body diode voltage	V_{SD}	$I_S = 5 A, V_{GS} = 0 V$	-	0.7	1.1	V	
Body diode reverse recovery time	t _{rr}		-	80	160	ns	
Body diode reverse recovery charge	Q_{rr}	1 10 A 4:/44 100 A/ - T 05 00	-	144	290	nC	
Reverse recovery fall time	ta	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	43	-	ns	
Reverse recovery rise time	t _b		_	37	-		

Notes

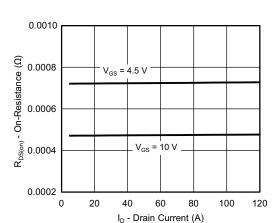
- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

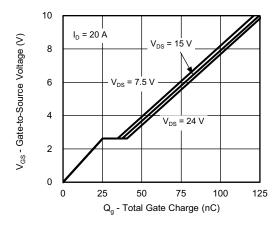




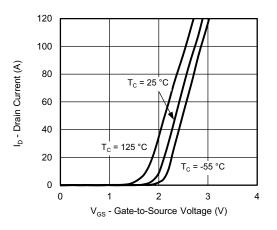
Output Characteristics



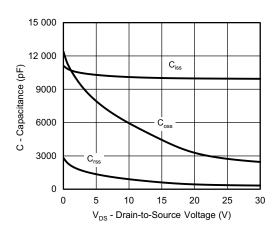
On-Resistance vs. Drain Current and Gate Voltage



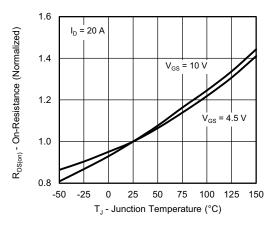
Gate Charge



Transfer Characteristics

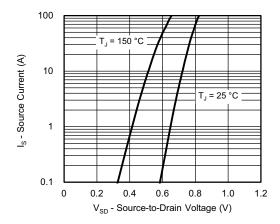


Capacitance

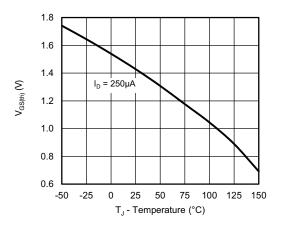


On-Resistance vs. Junction Temperature

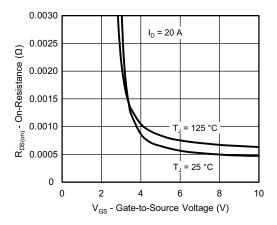




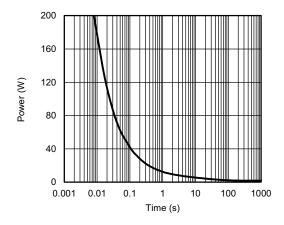
Source-Drain Diode Forward Voltage



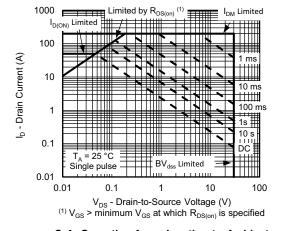
Threshold Voltage

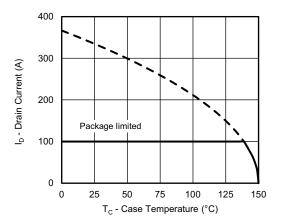


On-Resistance vs. Gate-to-Source Voltage

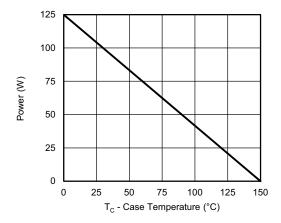


Single Pulse Power, Junction-to-Ambient





Current Derating a

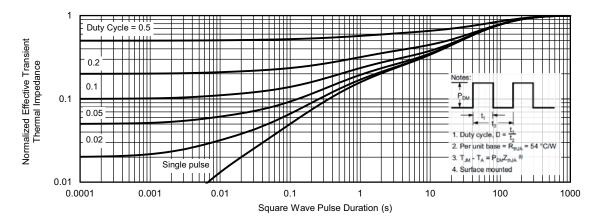


Power, Junction-to-Case

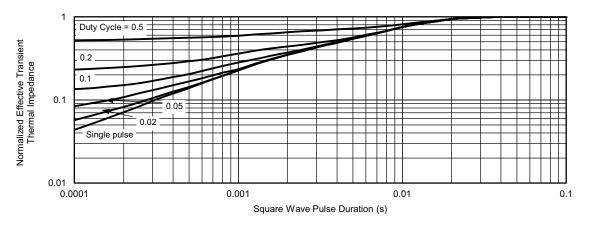
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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